

Notice of References Cited	Application/Control No. 09/754,905	Applicant(s)/Patent Under Reexamination SYDON ET AL.	
	Examiner Steven HD Nguyen	Art Unit 2665	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,515,366	05-1996	Chieu et al.	370/347
	B	US-5,636,243	06-1997	Tanaka, Syoichi	370/350
	C	US-5,748,621	05-1998	Masuda et al.	370/350
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2285723 A	07-1995	United Kingdom	VAN DEN HEUVEL et al.	H04B 07/26
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.